# **Course Manual TO**

Technical optics

Version: 1 | Last Change: 19.09.2019 15:08 | Draft: 0 | Status: vom verantwortlichen Dozent freigegeben

## - General information

| Long name            | Technical optics   |
|----------------------|--|
| Approving CModule    | <u>TO_BaET, TO_BaOPT</u>   |
| Responsible          | Prof. Dr. Stefan<br>Altmeyer<br>Professor Fakultät IME   |
| Valid from           | summer semester 2022   |
| Level                | Bachelor   |
| Semester in the year | summer semester  |
| Duration             | Semester   |
| Hours in self-study  | 78   |
| ECTS                 | 5  |
| Professors           | Prof. Dr. Stefan<br>Altmeyer<br>Professor Fakultät IME   |
| Requirements         | mathematics:<br>differntial calculus<br>integral calculus<br>physics / optics:<br>basics of geometrical<br>optics<br>basics of wave optics |
| Language             | German   |
| Separate final exam  | Yes  |
|                      |  |

## Literature

Pedrotti, Pedrotti, Bausch, Schmidt: Optik für Ingenieure. Grundlagen (Springer)

Hecht: Optik (Oldenbourg)

Final exam

### Details

Standard for this lecture is a written exam.

If the number of participants is not too high, an oral examination is preferred over written exams.

Lowest competence level checked is knowledge. Questions could address the sign convention, the structure of the imaging equation in dependence of light direction, the definition of the principal ray or the labelling of optical components conforming to industry standards.

The next competence level is related to skills. Examination could be done by the task to draw the optical path of rays of optical systems whereas the qualitative correct position of functional planes is important. Furthermore calculations can be performed, e.g. the resolution of optical systems, the image shift in systems with regions of differing refractive indices, of the overall focal length of a compund system.

The highest competence level adressed is methodical expertise. It can be checked by a real world task: E.g. the design of a microscope with an own light source where some application paramters to achieve are given or some off the shelf components are given. In a guided discussion or guided calculation it can be found out easily, if the underlying principles

| k<br>i<br>r | re understood and can<br>be applied proactively,<br>f intellectual transfer is<br>nade and if there is<br>ufficient overview. |  |
|-------------|---|--|
|             | Correct answer of at<br>east 50 % of the<br>juestions   |  |
| Exam Type   | N Klausur   |  |

## - Lecture / Exercises

## Learning goals

Goal type Description

## Special requirements

none

Accompanying material lecture notes as downloadable file

Separate exam

No

#### Knowledge

maginification reproduction scale angular magnification magnifier magnification axial magnification

cardinal planes and points node points and focal points in optical systems with asymmetric refrective indices intendes shift of principal planes telephoto lens reverse telephot lens, laser material processing

multi lens systems

analytical calculation of a doublet focal group of a camera accessory lenses for macro photos calculation of multi lens systems by repeated doublet calculation approach of lens grouping in objectives

#### image shift

under water photography special microscopy objectives foruse with cover glass optical aberrations of planeparallel glass sheets

Principle of Fermat derivation of the law of refraction wave-optical explaination of the properties of a lens derivation of the sine condition

Aperture and F# number aperture of a glass fiber of an optical imaging system F# number written F# number effective F# number relation of aperture and (effective) F# number object- and image-related apertures and F# numbers image brightness and exposure time

diffraction at a circular apertur mathematical description criteria for resolution Rayleigh criterium Sparrow criteriium size of the Airy disc smallest resolvable distance in the object and in the image in terms of the apertures and F# numbers beneficial and empty magnification technical examples: optical lithography, microscope, optical pickup for CD/DVD/blu-ray

### lenses

imaging lens: glass and plastics field lens: suitability of Fresnel lenses, requirements regarding dust

hard apertures and images of them aperture stop and field stop pupils and portholes principal rays complementary roles of apertureand field-stops in imaging- and lighting-raypaths principles of construction for optical devices with own light sources. Examples: overheadprojector, beamer, microscope

### Microscopes

simple and joint with and without field lens reflection and transmission Köhler illumination interwoven light ptahs of imaging and illumination path

If there is enough time in the semester:

Abbe's theory of imaging Decomposition of any object into gratings, Fourier decomposition Diffraction orders: number of and phas-relationship limiting resolution contrast off-axis illumination how to build resolution enhancement decrease of contrast principles of construction of a lithography machine

| Skills                         | Analyse, calculate and design multi lens optical systems paraxially  |  |  |  |
|--------------------------------|--|--|--|--|
|                                | Shift the principal planes to<br>intended locations in optical<br>systems.   |  |  |  |
|                                | Convert Apertured and F#<br>numbers on the object- and image<br>side.  |  |  |  |
|                                | Calculate imaging resolution of optical systems on the object- and image side.   |  |  |  |
|                                | Calculate the image shift.   |  |  |  |
|                                | Calculate the resolution loss due to<br>angular dependent image shift of<br>high aperture systems.   |  |  |  |
|                                | Design raypaths of optical systems<br>with integrated illumination<br>Transfer the principles of<br>construction of different<br>microscope types to other optical<br>devices. |  |  |  |
|                                |  |  |  |  |
|                                | Calculate the contrast of optical on- and off-axis systems   |  |  |  |
| Expenditure classroom teaching |  |  |  |  |
| Туре                           | Attendance (h/Wk.)   |  |  |  |
| Lecture                        | 2  |  |  |  |
| Tutorial (voluntary) 0         |  |  |  |  |

## - Practical training

| Goal type  | Description  | none                     |  |
|--|--|--------------------------|--|
| <ul> <li>Skills - Build and align a Gallilei and a<br/>Kepler telescope</li> <li>Determine the focal lenght of an<br/>objective with the method of<br/>Abbe, Bessel or different</li> <li>Determine the principal planes<br/>with the method of Abbe of by<br/>extrapolation of the reproduction<br/>scale</li> <li>Determine the resolution of a<br/>microscope with Köhler</li> </ul>  | -  |                          |  |
|  | objective with the method of                           | Accompanying<br>material | Instrcutions for the experiments as downloadable files.              |
|  | with the method of Abbe of by                          |                          | Operating manuals for<br>complex equipment as<br>downloadable files. |
|  | Separate exam  | Yes                      |  |
|  | - Determine the resolution of a microscope with Köhler |                          |  |
|  | illumination   | Separate exam            |  |
| <ul> <li>Determine image brightness in a microscope in dependence of reproduction scale and aperture.</li> <li>Watch and compare the object and the diffraction image in the Fourier plane in a diffraction apparatus. Perform intended image manipulations by modifications in the Fourier plane. Achieve e.g. a spatial frequency doubling.</li> <li>write scientific report describe the task descirbe the idea of the solution explain the data processing make error analysis present the results and make a critical discussion</li> </ul> | microscope in dependence of                            | Exam Type                | EN Projektaufgabe im<br>Team bearbeiten (z.B.                        |
|  |  |                          | im Praktikum)  |
|  | - 1  |                          |  |
|  |  |                          |  |
|  | Achieve e.g. a spatial frequency                       |                          |  |
|  | · · · · · · · · · · · · · · · · · · ·                  |                          |  |
|  | descirbe the idea of the solution                      |                          |  |
|  |  |                          |  |
|  | present the results and make a                         |                          |  |
| vnenditure   | e classroom teaching                                   |                          |  |
| Apenuiture   |  |                          |  |
| Туре   | Attendance (h/Wk.)                                     |                          |  |
| Practical trair  | ning 2   |                          |  |
| Tutorial (volu   | ntary) 0   |                          |  |
|  |  |                          |  |

| Details          | 1) Written examination<br>questions related to the<br>experiment have to be<br>prepared at home and<br>shown at the beginning<br>of the laboratory.  |
|------------------|--|
|                  | 2) The underlying ideas<br>of the experiment have<br>to be explained at the<br>beginning of the<br>laboratory.   |
|                  | <ul> <li>3) Make the experiment<br/>alone (preferred) or in a<br/>team of two.</li> <li>Build up and adjust<br/>your own setup</li> <li>Acquire / measure<br/>date with this setup</li> </ul>  |
|                  | <ul> <li>4) Write a</li> <li>documentation on the experiment. It will be checked wih regard to</li> <li>completness</li> <li>scientific and precise language</li> <li>correctness</li> <li>understanding of the interrellations and interpretation of the results</li> </ul> |
| Minimum standard | All written tasks must<br>have been delt with.   |
|                  | The basic ideas of the experiment must have been understood.   |
|                  | All experiments must have been performed.  |
|                  | The reports must be free of systematical   |

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